

SHENZHEN YINTK ELECTRONICS CO., LTD

URGEKHKECVKQPU

FCVG

423: 34 7

EWUVQOGT

KVGO

[NHY2825/322M*ht

S)V [0"

RCTV"PQ0

VGOR 47 "

JWOKFKV [

92 '

1.SHAPE & DIMENSION

UNIT:mm

EQFG

N

Y

V

G

H

F

FKOGPUKQP 30:2OCZ 3047OCZ 3042OCZ 2086V{r0 3024V{r0 2086V{r0

2. ELECTRICAL

SHENZHEN YINTK ELECTRONICS CO., LTD

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EWUVQOGT	KVGO	[NHY2825/322M*ht
S)V [0"	RCTV"PQ0	/
VGOR	JWOKFKV [92 '

5. TEST DATA FOR SAMPLES

VGUV"*****	N	S*	+	FET	N	Y	V
KVGO	* J+	* o k p+	* +	* o o+	* o o+	* o o+	* o o+
EQP0	4070 J	4070 J	Cv"47	30:20CZ	30470CZ	30420CZ	
URG							

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/

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6. SOLDERING CONDITIONS

Figure 1.

Re-flow

Soldering (Lead

Free)

Pqvg

\$

"

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EV QOGT

Y 282 22M*ht

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8.1 RELIABILITY TEST

VGUV"KVGO

URGEKHKECVKQP

VGUV"EQPFVKQP

Tcvkpi"ewttgpv

Ceeqtfkpi"vq"rtqfwev"
urgekhecvkqpu

Ewttgpv"uqwtegu<55232F

kpfwevpeg

Ceeqtfkpi"vq"rtqfwev"
urgekhecvkqpu

VgUV"Htgswgpe{<20474ø472O J|"VgUV"
Gswkr o gpv<JR64;3C JR64:8C JR64:9C
JR64:6C"VgUV"Hkzvwtg<383;5Cqt38556

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[NHY2825/322M*